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LISTOF	KEFE	KENCES CITED BY AP	PLICANT	Masami NASU			
				FILING DATE		GROUP	
				March 29, 2004		2136	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS		SUB FILING DATE CLASS IF APPROPRIATE	
	AA	2002/0046189 A1	04/18/2002	Akira MORITA, et al.			
	AB	6,332,139 B1	12/18/2001	Toshikazu KANEKO, et al.			
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
	AO	JP 10-145354	05/29/1998	Japan (with English Abstract)			Х
	AP	JP 2002-41295	02/08/2002	Japan (with English Abstract)			Х
	AQ	JP 2002-123779	04/26/2002	Japan (corresponding to US 2002/0046189 A1)			Х
	AR	JP 2001-75965	03/23/2001	Japan (corresponding to US 6,332,139 B1)			Х
	AS						
	ΑT						
	AU						
	ΑV					***	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
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	AZ				☐ ∧ddii	ional Dofo	ronges shoot(s) attached
Examiner					Additional References sheet(s) attached Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in							
conformance and not considered. Include copy of this form with next communication to applicant.							